

Notice of References CitedApplication/Control No.
09/928,975Applicant(s)/Patent Under
Reexamination
HERNER ET AL.Examiner
Thomas J. MageeArt Unit
2811

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0045342 A1	04-2002	Yongjun Hu et al.	438/656
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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